

FIRST INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Complete if Known

Application Number	New U.S. Patent Application
Filing Date	March 4, 2004
First Named Inventor	Jin-ho LEE et al.
Examiner Name	Unassigned
Attorney Docket Number	030681-636

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NON-PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
[Signature]	P.F. INDERMUEHLE et al.; Design and Fabrication of an Overhanging xy-microactuator with Integrated Tip for Scanning Surface Profiling; May 1, 1994; pages 346-350; Vol. A43, No. 1/3; Sensors and Actuators A, Elsevier Sequoia S.A., Lausanne, Switzerland

Examiner Signature

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